

Search Notes

Application/Control No.

10/611,630

Examiner

Mellissa M. Chojnacki

Applicant(s)/Patent under
Reexamination

AARON, JEFFREY A.

Art Unit

2164

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched EAST, USPTO, JPO, EPO, IBM_TDB, PGPUB, Strategy enclosed.	5/3/2007	MMC
Consulted Examiner Neveen Abel-Jalil and Primary Examiner Sam Rimell regarding art and office action.	5/3/2007	MMC
Did Inventor Search.	5/3/2007	MMC